

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10569714	MEYER ET AL.
	Examiner	Art Unit
	Chen, Catheryne	1655

SEARCHED

Class	Subclass	Date	Examiner
none	none	1/22/08	CC

SEARCH NOTES

Search Notes	Date	Examiner
INVENTOR NAME, USPT, PGPB, JPAB, EPAB, DWPI, MEDLINE, EMBASE, BIOSIS, CAPLUS, REGISTRY	1/22/08	CC
updated search	10/20/08	CC
updated search	11/2/09	CC
updated search	6/16/10	CC
updated search	1/13/11	CC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/CATHERYNE CHEN/
Examiner.Art Unit 1655